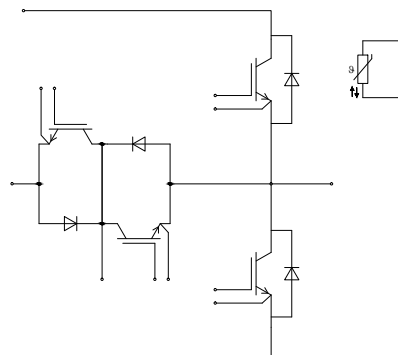
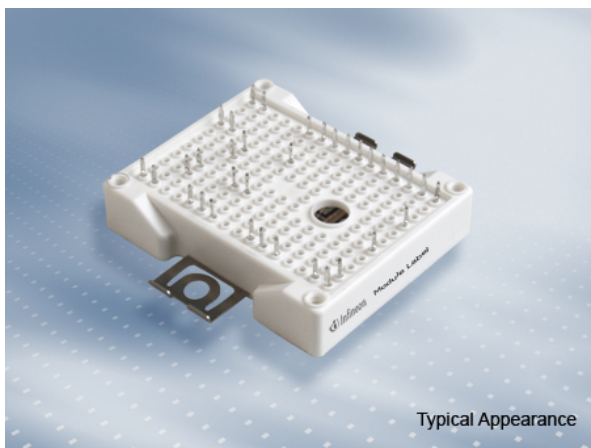


EasyPACK モジュール ニュートラル ポイント クランプ2 トポロジー内蔵 and PressFIT / NTCサーミスタ
EasyPACK module with active "Neutral Point Clamp 2" topology and PressFIT / NTC

暫定データ / Preliminary Data



$V_{CES} = 1200V$
 $I_{C\ nom} = 50A / I_{CRM} = 100A$

一般応用

- 3レベル アプリケーション
- ソーラーアプリケーション

Typical Applications

- 3-Level-Applications
- Solar Applications

電気的特性

- 高速IGBT H3
- 低スイッチング損失
- $T_{vj\ op} = 150^{\circ}C$

Electrical Features

- High Speed IGBT H3
- Low Switching Losses
- $T_{vj\ op} = 150^{\circ}C$

機械的特性

- PressFIT 接合 技術
- RoHS対応

Mechanical Features

- PressFIT Contact Technology
- RoHS compliant

Module Label Code

Barcode Code 128



Content of the Code

Digit

Module Serial Number	1 - 5
Module Material Number	6 - 11
Production Order Number	12 - 19
Datecode (Production Year)	20 - 21
Datecode (Production Week)	22 - 23

DMX - Code



prepared by: CM	date of publication: 2015-02-03	
approved by: AKDA	revision: 2.3	UL approved (E83335)



暫定データ
Preliminary Data

IGBT, T1 / T4 / IGBT, T1 / T4
最大定格 / Maximum Rated Values

コレクタ・エミッタ間電圧 Collector-emitter voltage	$T_{vj} = 25^{\circ}\text{C}$	V_{CES}	1200	V
コレクタ電流 Implemented collector current		I_{CN}	100	A
連続DCコレクタ電流 Continuous DC collector current	$T_C = 100^{\circ}\text{C}, T_{vj\max} = 175^{\circ}\text{C}$	$I_{C\text{nom}}$	50	A
繰り返しピークコレクタ電流 Repetitive peak collector current	$t_P = 1\text{ms}$	I_{CRM}	200	A
トータル損失 Total power dissipation	$T_C = 25^{\circ}\text{C}, T_{vj\max} = 175^{\circ}\text{C}$	P_{tot}	375	W
ゲート・エミッタ間ピーク電圧 Gate-emitter peak voltage		V_{GES}	+/-20	V

電気的特性 / Characteristic Values

			min.	typ.	max.	
コレクタ・エミッタ間飽和電圧 Collector-emitter saturation voltage	$I_C = 50\text{A}, V_{GE} = 15\text{V}$ $I_C = 50\text{A}, V_{GE} = 15\text{V}$ $I_C = 50\text{A}, V_{GE} = 15\text{V}$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	$V_{CE\text{sat}}$	1,55 1,70 1,75	1,75	V V V
ゲート・エミッタ間しきい値電圧 Gate threshold voltage	$I_C = 3,80\text{mA}, V_{CE} = V_{GE}, T_{vj} = 25^{\circ}\text{C}$		$V_{G\text{Eth}}$	5,05	5,80	6,45 V
ゲート電荷量 Gate charge	$V_{GE} = -15\text{V} \dots +15\text{V}$		Q_G	0,80		μC
内蔵ゲート抵抗 Internal gate resistor	$T_{vj} = 25^{\circ}\text{C}$		$R_{G\text{int}}$	7,5		Ω
入力容量 Input capacitance	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		C_{ies}	6,15		nF
帰還容量 Reverse transfer capacitance	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		C_{res}	0,345		nF
コレクタ・エミッタ間遮断電流 Collector-emitter cut-off current	$V_{CE} = 1200\text{V}, V_{GE} = 0\text{V}, T_{vj} = 25^{\circ}\text{C}$		I_{CES}		1,0	mA
ゲート・エミッタ間漏れ電流 Gate-emitter leakage current	$V_{CE} = 0\text{V}, V_{GE} = 20\text{V}, T_{vj} = 25^{\circ}\text{C}$		I_{GES}		100	nA
ターンオン遅れ時間 (誘導負荷) Turn-on delay time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Gon} = 1,1\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	$t_{d\text{on}}$	0,13 0,14 0,145		μs μs μs
ターンオン上昇時間 (誘導負荷) Rise time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Gon} = 1,1\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	t_r	0,02 0,03 0,03		μs μs μs
ターンオフ遅れ時間 (誘導負荷) Turn-off delay time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Goff} = 1,1\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	$t_{d\text{off}}$	0,30 0,38 0,40		μs μs μs
ターンオフ下降時間 (誘導負荷) Fall time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Goff} = 1,1\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	t_f	0,03 0,06 0,065		μs μs μs
ターンオンスイッチング損失 Turn-on energy loss per pulse	$I_C = 50\text{A}, V_{CE} = 400\text{V}, L_S = 25\text{nH}$ $V_{GE} = \pm 15\text{V}, di/dt = 2200\text{A}/\mu\text{s} (T_{vj} = 150^{\circ}\text{C})$ $R_{Gon} = 1,1\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	E_{on}	1,05 1,65 1,80		mJ mJ mJ
ターンオフスイッチング損失 Turn-off energy loss per pulse	$I_C = 50\text{A}, V_{CE} = 400\text{V}, L_S = 25\text{nH}$ $V_{GE} = \pm 15\text{V}, du/dt = 2400\text{V}/\mu\text{s} (T_{vj} = 150^{\circ}\text{C})$ $R_{Goff} = 1,1\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	E_{off}	1,60 2,60 2,95		mJ mJ mJ
短絡電流 SC data	$V_{GE} \leq 15\text{V}, V_{CC} = 800\text{V}$ $V_{CE\text{max}} = V_{CES} - L_{SCE} \cdot di/dt$ $t_P \leq 10\mu\text{s}, T_{vj} = 150^{\circ}\text{C}$		I_{SC}	400		A
ジャンクション・ケース間熱抵抗 Thermal resistance, junction to case	IGBT部 (1素子当り) / per IGBT		$R_{th\text{JC}}$	0,30	0,40	K/W

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暫定データ
Preliminary Data

ケース・ヒートシンク間熱抵抗 Thermal resistance, case to heatsink	IGBT部 (1 素子当り) / per IGBT $\lambda_{\text{Paste}} = 1 \text{ W}/(\text{m}\cdot\text{K})$ / $\lambda_{\text{grease}} = 1 \text{ W}/(\text{m}\cdot\text{K})$	R_{thCH}		0,35		K/W
動作温度 Temperature under switching conditions		$T_{\text{vj op}}$	-40		150	°C

ダイオード, D2 / D3 / Diode, D2 / D3

最大定格 / Maximum Rated Values

ピーク繰返し逆電圧 Repetitive peak reverse voltage	$T_{\text{vj}} = 25^\circ\text{C}$	V_{RRM}	650	V
順電流 Implemented forward current		I_{FN}	100	A
連続DC電流 Continuous DC forward current		I_{F}	50	A
ピーク繰返し順電流 Repetitive peak forward current	$t_{\text{p}} = 1 \text{ ms}$	I_{FRM}	200	A
電流二乗時間積 I^2t - value	$V_{\text{R}} = 0 \text{ V}, t_{\text{p}} = 10 \text{ ms}, T_{\text{vj}} = 125^\circ\text{C}$ $V_{\text{R}} = 0 \text{ V}, t_{\text{p}} = 10 \text{ ms}, T_{\text{vj}} = 150^\circ\text{C}$	I^2t	850 800	A ² s A ² s

電気的特性 / Characteristic Values

			min.	typ.	max.	
順電圧 Forward voltage	$I_{\text{F}} = 50 \text{ A}, V_{\text{GE}} = 0 \text{ V}$ $I_{\text{F}} = 50 \text{ A}, V_{\text{GE}} = 0 \text{ V}$ $I_{\text{F}} = 50 \text{ A}, V_{\text{GE}} = 0 \text{ V}$	$T_{\text{vj}} = 25^\circ\text{C}$ $T_{\text{vj}} = 125^\circ\text{C}$ $T_{\text{vj}} = 150^\circ\text{C}$	V_{F}	1,35 1,30 1,25	1,60	V V V
ピーク逆回復電流 Peak reverse recovery current	$I_{\text{F}} = 50 \text{ A}, -di_{\text{F}}/dt = 2200 \text{ A}/\mu\text{s} (T_{\text{vj}}=150^\circ\text{C})$ $V_{\text{R}} = 400 \text{ V}$ $V_{\text{GE}} = -15 \text{ V}$	$T_{\text{vj}} = 25^\circ\text{C}$ $T_{\text{vj}} = 125^\circ\text{C}$ $T_{\text{vj}} = 150^\circ\text{C}$	I_{RM}	52,0 57,0 59,0		A A A
逆回復電荷量 Recovered charge	$I_{\text{F}} = 50 \text{ A}, -di_{\text{F}}/dt = 2200 \text{ A}/\mu\text{s} (T_{\text{vj}}=150^\circ\text{C})$ $V_{\text{R}} = 400 \text{ V}$ $V_{\text{GE}} = -15 \text{ V}$	$T_{\text{vj}} = 25^\circ\text{C}$ $T_{\text{vj}} = 125^\circ\text{C}$ $T_{\text{vj}} = 150^\circ\text{C}$	Q_{r}	1,90 3,60 4,10		μC μC μC
逆回復損失 Reverse recovery energy	$I_{\text{F}} = 50 \text{ A}, -di_{\text{F}}/dt = 2200 \text{ A}/\mu\text{s} (T_{\text{vj}}=150^\circ\text{C})$ $V_{\text{R}} = 400 \text{ V}$ $V_{\text{GE}} = -15 \text{ V}$	$T_{\text{vj}} = 25^\circ\text{C}$ $T_{\text{vj}} = 125^\circ\text{C}$ $T_{\text{vj}} = 150^\circ\text{C}$	E_{rec}	0,45 0,75 0,85		mJ mJ mJ
ジャンクション・ケース間熱抵抗 Thermal resistance, junction to case	/Diode (1 素子当り) / per diode		R_{thJC}	0,55	0,70	K/W
ケース・ヒートシンク間熱抵抗 Thermal resistance, case to heatsink	/Diode (1 素子当り) / per diode $\lambda_{\text{Paste}} = 1 \text{ W}/(\text{m}\cdot\text{K})$ / $\lambda_{\text{grease}} = 1 \text{ W}/(\text{m}\cdot\text{K})$		R_{thCH}	0,65		K/W
動作温度 Temperature under switching conditions			$T_{\text{vj op}}$	-40	150	°C

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暫定データ
Preliminary Data

IGBT, T2 / T3 / IGBT, T2 / T3
最大定格 / Maximum Rated Values

コレクタ・エミッタ間電圧 Collector-emitter voltage	$T_{vj} = 25^{\circ}\text{C}$	V_{CES}	650	V
連続DCコレクタ電流 Continuous DC collector current	$T_C = 75^{\circ}\text{C}, T_{vj\max} = 175^{\circ}\text{C}$	$I_{C\text{nom}}$	50	A
繰り返しピークコレクタ電流 Repetitive peak collector current	$t_P = 1\text{ms}$	I_{CRM}	100	A
トータル損失 Total power dissipation	$T_C = 25^{\circ}\text{C}, T_{vj\max} = 175^{\circ}\text{C}$	P_{tot}	175	W
ゲート・エミッタ間ピーク電圧 Gate-emitter peak voltage		V_{GES}	+/-20	V

電気的特性 / Characteristic Values

			min.	typ.	max.		
コレクタ・エミッタ間飽和電圧 Collector-emitter saturation voltage	$I_C = 50\text{A}, V_{GE} = 15\text{V}$ $I_C = 50\text{A}, V_{GE} = 15\text{V}$ $I_C = 50\text{A}, V_{GE} = 15\text{V}$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	$V_{CE\text{sat}}$	1,45 1,60 1,70	1,90	V V V	
ゲート・エミッタ間しきい値電圧 Gate threshold voltage	$I_C = 0,80\text{mA}, V_{CE} = V_{GE}, T_{vj} = 25^{\circ}\text{C}$		V_{GEth}	4,90	5,80	6,50	V
ゲート電荷量 Gate charge	$V_{GE} = -15\text{V} \dots +15\text{V}$		Q_G	0,50		μC	
内蔵ゲート抵抗 Internal gate resistor	$T_{vj} = 25^{\circ}\text{C}$		R_{Gint}	0,0		Ω	
入力容量 Input capacitance	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		C_{ies}	3,10		nF	
帰還容量 Reverse transfer capacitance	$f = 1\text{MHz}, T_{vj} = 25^{\circ}\text{C}, V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$		C_{res}	0,095		nF	
コレクタ・エミッタ間遮断電流 Collector-emitter cut-off current	$V_{CE} = 650\text{V}, V_{GE} = 0\text{V}, T_{vj} = 25^{\circ}\text{C}$		I_{CES}		1,0	mA	
ゲート・エミッタ間漏れ電流 Gate-emitter leakage current	$V_{CE} = 0\text{V}, V_{GE} = 20\text{V}, T_{vj} = 25^{\circ}\text{C}$		I_{GES}		100	nA	
ターンオン遅れ時間 (誘導負荷) Turn-on delay time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Gon} = 8,2\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	t_{don}	0,025 0,025 0,025		μs μs μs	
ターンオン上昇時間 (誘導負荷) Rise time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Gon} = 8,2\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	t_r	0,017 0,021 0,022		μs μs μs	
ターンオフ遅れ時間 (誘導負荷) Turn-off delay time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Goff} = 8,2\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	t_{doff}	0,19 0,22 0,25		μs μs μs	
ターンオフ下降時間 (誘導負荷) Fall time, inductive load	$I_C = 50\text{A}, V_{CE} = 400\text{V}$ $V_{GE} = \pm 15\text{V}$ $R_{Goff} = 8,2\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	t_f	0,033 0,05 0,055		μs μs μs	
ターンオンスイッチング損失 Turn-on energy loss per pulse	$I_C = 50\text{A}, V_{CE} = 400\text{V}, L_S = 25\text{nH}$ $V_{GE} = \pm 15\text{V}, di/dt = 2600\text{A}/\mu\text{s} (T_{vj} = 150^{\circ}\text{C})$ $R_{Gon} = 8,2\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	E_{on}	1,10 1,75 1,90		mJ mJ mJ	
ターンオフスイッチング損失 Turn-off energy loss per pulse	$I_C = 50\text{A}, V_{CE} = 400\text{V}, L_S = 25\text{nH}$ $V_{GE} = \pm 15\text{V}, du/dt = 4000\text{V}/\mu\text{s} (T_{vj} = 150^{\circ}\text{C})$ $R_{Goff} = 8,2\Omega$	$T_{vj} = 25^{\circ}\text{C}$ $T_{vj} = 125^{\circ}\text{C}$ $T_{vj} = 150^{\circ}\text{C}$	E_{off}	1,50 2,05 2,20		mJ mJ mJ	
短絡電流 SC data	$V_{GE} \leq 15\text{V}, V_{CC} = 360\text{V}$ $V_{CEmax} = V_{CES} - L_{SCE} \cdot di/dt$	$t_P \leq 8\mu\text{s}, T_{vj} = 25^{\circ}\text{C}$ $t_P \leq 6\mu\text{s}, T_{vj} = 150^{\circ}\text{C}$	I_{SC}	350 250		A A	
ジャンクション・ケース間熱抵抗 Thermal resistance, junction to case	IGBT部 (1素子当り) / per IGBT		R_{thJC}	0,75	0,85	K/W	
ケース・ヒートシンク間熱抵抗 Thermal resistance, case to heatsink	IGBT部 (1素子当り) / per IGBT $\lambda_{\text{Paste}} = 1\text{W}/(\text{m}\cdot\text{K}) / \lambda_{\text{grease}} = 1\text{W}/(\text{m}\cdot\text{K})$		R_{thCH}	0,70		K/W	
動作温度 Temperature under switching conditions			$T_{vj\text{op}}$	-40	150	$^{\circ}\text{C}$	

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暫定データ
Preliminary Data

ダイオード, D1 / D4 / Diode, D1 / D4
最大定格 / Maximum Rated Values

ピーク繰返し逆電圧 Repetitive peak reverse voltage	$T_{vj} = 25^{\circ}\text{C}$	V_{RRM}	1200	V
連続DC電流 Continuous DC forward current		I_F	35	A
ピーク繰返し順電流 Repetitive peak forward current	$t_P = 1\text{ ms}$	I_{FRM}	150	A
電流二乗時間積 I^2t - value	$V_R = 0\text{ V}, t_P = 10\text{ ms}, T_{vj} = 125^{\circ}\text{C}$	I^2t	510	A^2s
	$V_R = 0\text{ V}, t_P = 10\text{ ms}, T_{vj} = 150^{\circ}\text{C}$		450	A^2s

電気的特性 / Characteristic Values

			min.	typ.	max.	
順電圧 Forward voltage	$I_F = 35\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 25^{\circ}\text{C}$		2,00	2,55	V
	$I_F = 35\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 125^{\circ}\text{C}$		1,70		V
	$I_F = 35\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 150^{\circ}\text{C}$		1,65		V
ピーク逆回復電流 Peak reverse recovery current	$I_F = 35\text{ A}, -di_F/dt = 2400\text{ A}/\mu\text{s} (T_{vj}=150^{\circ}\text{C})$ $V_R = 400\text{ V}$ $V_{GE} = -15\text{ V}$	$T_{vj} = 25^{\circ}\text{C}$		70,0		A
		$T_{vj} = 125^{\circ}\text{C}$		85,0		A
		$T_{vj} = 150^{\circ}\text{C}$		90,0		A
逆回復電荷量 Recovered charge	$I_F = 35\text{ A}, -di_F/dt = 2400\text{ A}/\mu\text{s} (T_{vj}=150^{\circ}\text{C})$ $V_R = 400\text{ V}$ $V_{GE} = -15\text{ V}$	$T_{vj} = 25^{\circ}\text{C}$		2,40		μC
		$T_{vj} = 125^{\circ}\text{C}$		5,70		μC
		$T_{vj} = 150^{\circ}\text{C}$		7,00		μC
逆回復損失 Reverse recovery energy	$I_F = 35\text{ A}, -di_F/dt = 2400\text{ A}/\mu\text{s} (T_{vj}=150^{\circ}\text{C})$ $V_R = 400\text{ V}$ $V_{GE} = -15\text{ V}$	$T_{vj} = 25^{\circ}\text{C}$		0,70		mJ
		$T_{vj} = 125^{\circ}\text{C}$		1,75		mJ
		$T_{vj} = 150^{\circ}\text{C}$		2,15		mJ
ジャンクション・ケース間熱抵抗 Thermal resistance, junction to case	/Diode (1 素子当り) / per diode	R_{thJC}		0,65	0,75	K/W
ケース・ヒートシンク間熱抵抗 Thermal resistance, case to heatsink	/Diode (1 素子当り) / per diode $\lambda_{Paste} = 1\text{ W}/(\text{m}\cdot\text{K}) / \lambda_{grease} = 1\text{ W}/(\text{m}\cdot\text{K})$	R_{thCH}		0,85		K/W
動作温度 Temperature under switching conditions		$T_{vj\text{ op}}$	-40		150	$^{\circ}\text{C}$

モジュール / Module

絶縁耐圧 Isolation test voltage	RMS, $f = 50\text{ Hz}, t = 1\text{ min.}$	V_{ISOL}	2,5	kV		
内部絶縁 Internal isolation	基礎絶縁 (クラス1, IEC 61140) basic insulation (class 1, IEC 61140)		Al_2O_3			
沿面距離 Creepage distance	連絡方法 - ヒートシンク / terminal to heatsink 連絡方法 - 連絡方法 / terminal to terminal		11,5 6,3	mm		
空間距離 Clearance	連絡方法 - ヒートシンク / terminal to heatsink 連絡方法 - 連絡方法 / terminal to terminal		10,0 5,0	mm		
相対トラッキング指数 Comperative tracking index		CTI	> 200			
内部インダクタンス Stray inductance module		L_{sCE}	14	nH		
保存温度 Storage temperature		T_{stg}	-40	125	$^{\circ}\text{C}$	
Anpresskraft für mech. Bef. pro Feder mounting force per clamp		F	40	-	80	N
質量 Weight		G	39		g	

Der Strom im Dauerbetrieb ist auf 25A effektiv pro Anschlusspin begrenzt.
The current under continuous operation is limited to 25A rms per connector pin.

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approved by: AKDA	revision: 2.3



暫定データ
Preliminary Data

NTC-サーミスタ / NTC-Thermistor

電気的特性 / Characteristic Values

		min.	typ.	max.	
定格抵抗値 Rated resistance	$T_C = 25^\circ\text{C}$	R_{25}		5,00	kΩ
R100の偏差 Deviation of R100	$T_C = 100^\circ\text{C}, R_{100} = 493 \Omega$	$\Delta R/R$	-5	5	%
損失 Power dissipation	$T_C = 25^\circ\text{C}$	P_{25}		20,0	mW
B-定数 B-value	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$	$B_{25/50}$		3375	K
B-定数 B-value	$R_2 = R_{25} \exp [B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$	$B_{25/80}$		3411	K
B-定数 B-value	$R_2 = R_{25} \exp [B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$	$B_{25/100}$		3433	K

適切なアプリケーションノートによる仕様
Specification according to the valid application note.

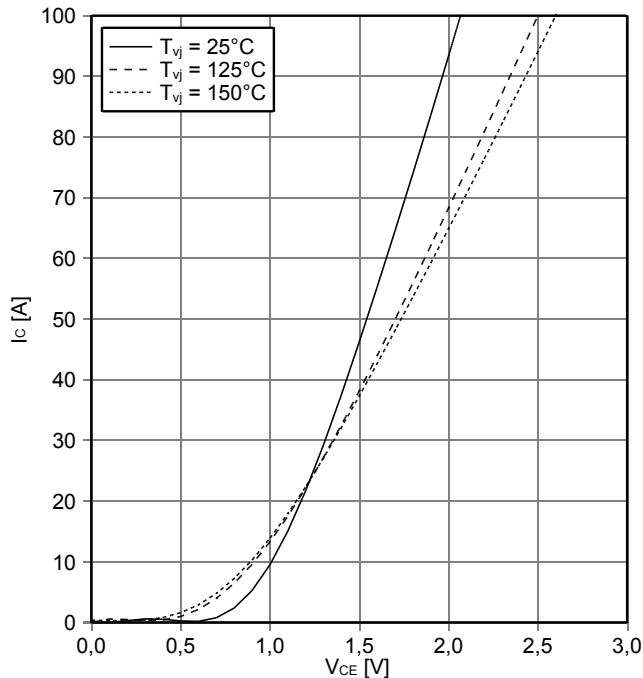
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暫定データ
Preliminary Data

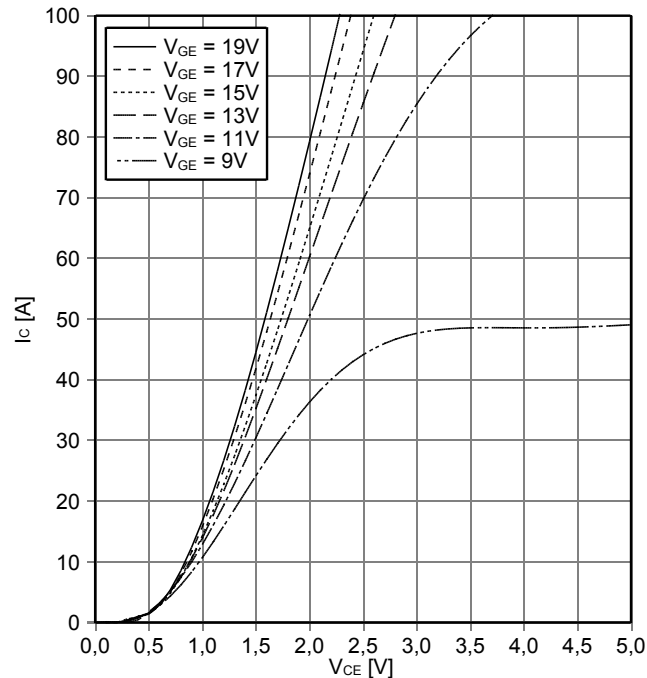
出力特性 IGBT, T1 / T4 (Typical)
output characteristic IGBT, T1 / T4 (typical)

$I_C = f(V_{CE})$
 $V_{GE} = 15\text{ V}$



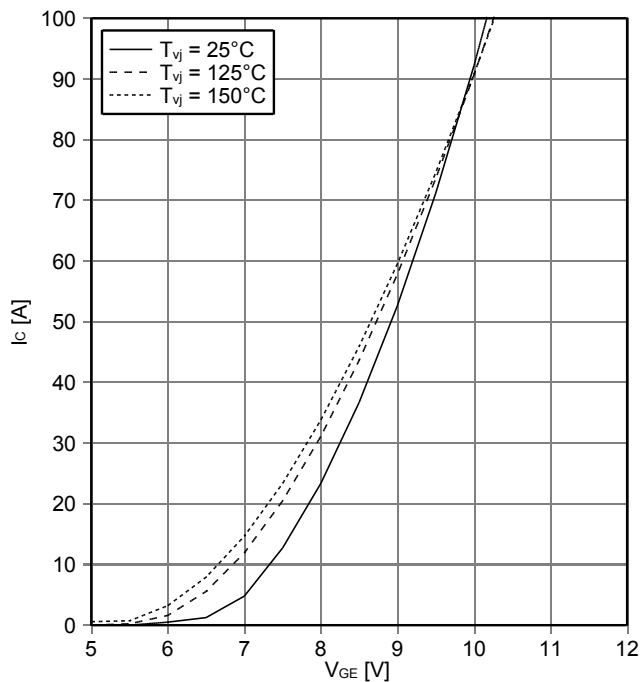
出力特性 IGBT, T1 / T4 (Typical)
output characteristic IGBT, T1 / T4 (typical)

$I_C = f(V_{CE})$
 $T_{vj} = 150^\circ\text{C}$



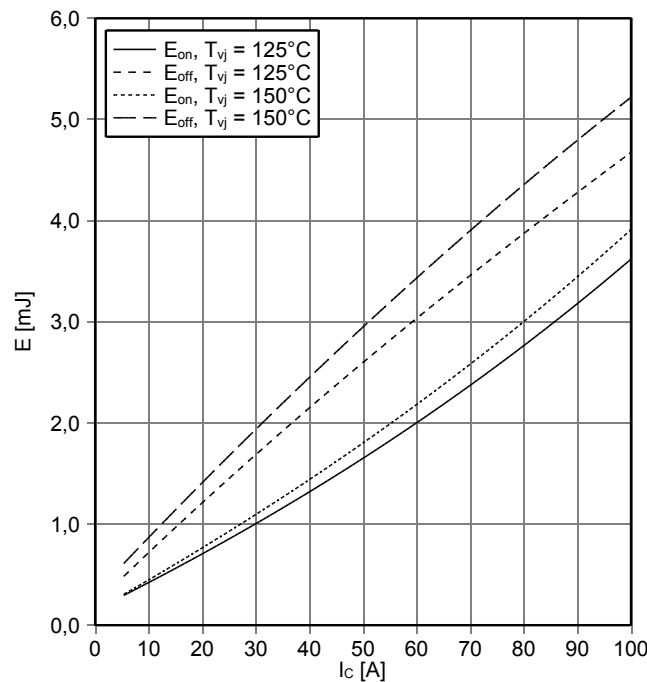
伝達特性 IGBT, T1 / T4 (Typical)
transfer characteristic IGBT, T1 / T4 (typical)

$I_C = f(V_{GE})$
 $V_{CE} = 20\text{ V}$



スイッチング損失 IGBT, T1 / T4 (Typical)
switching losses IGBT, T1 / T4 (typical)

$E_{on} = f(I_C)$, $E_{off} = f(I_C)$
 $V_{GE} = \pm 15\text{ V}$, $R_{Gon} = 1.1\ \Omega$, $R_{Goff} = 1.1\ \Omega$, $V_{CE} = 400\text{ V}$



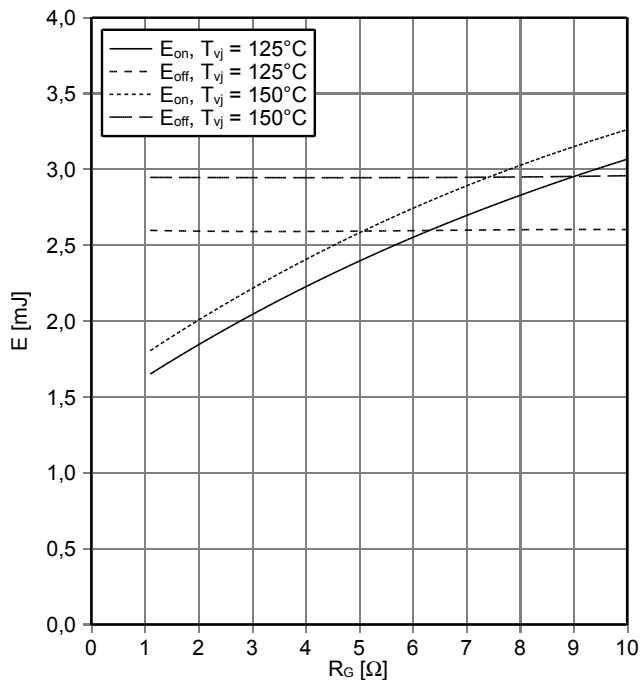
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Preliminary Data

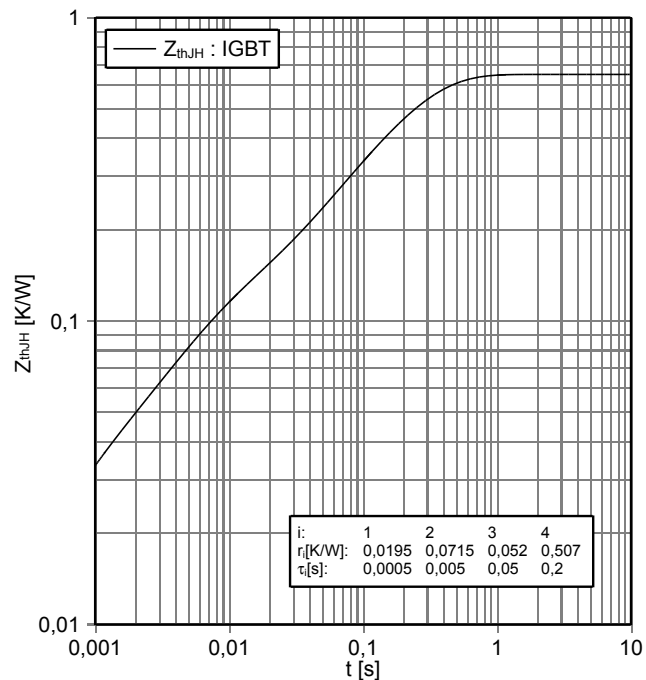
スイッチング損失 IGBT, T1 / T4 (Typical)
switching losses IGBT, T1 / T4 (typical)

$E_{on} = f(R_G)$, $E_{off} = f(R_G)$
 $V_{GE} = \pm 15\text{ V}$, $I_C = 50\text{ A}$, $V_{CE} = 400\text{ V}$



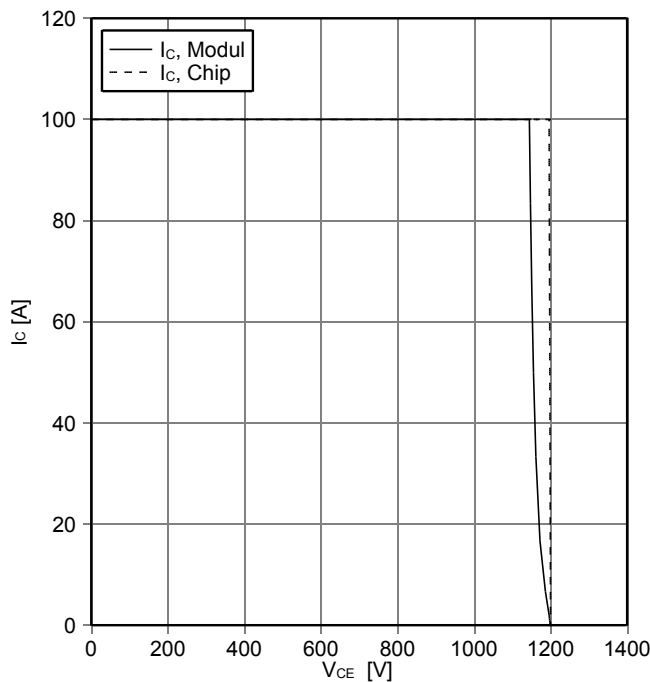
過渡熱インピーダンス IGBT, T1 / T4
transient thermal impedance IGBT, T1 / T4

$Z_{thJH} = f(t)$



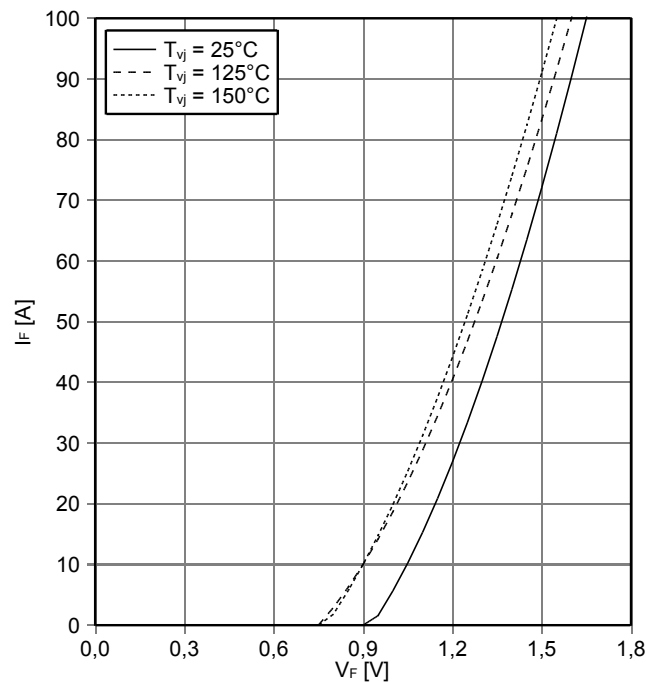
逆バイアス安全動作領域 IGBT, T1 / T4 (RBSOA)
reverse bias safe operating area IGBT, T1 / T4 (RBSOA)

$I_C = f(V_{CE})$
 $V_{GE} = \pm 15\text{ V}$, $R_{Goff} = 1.1\ \Omega$, $T_{vj} = 150^\circ\text{C}$



順電圧特性 ダイオード, D2 / D3 (typical)
forward characteristic of Diode, D2 / D3 (typical)

$I_F = f(V_F)$



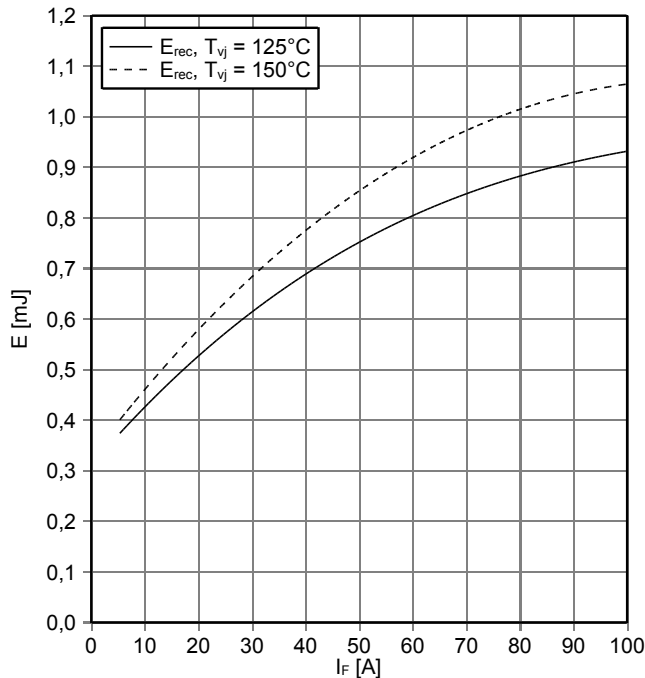
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暫定データ
Preliminary Data

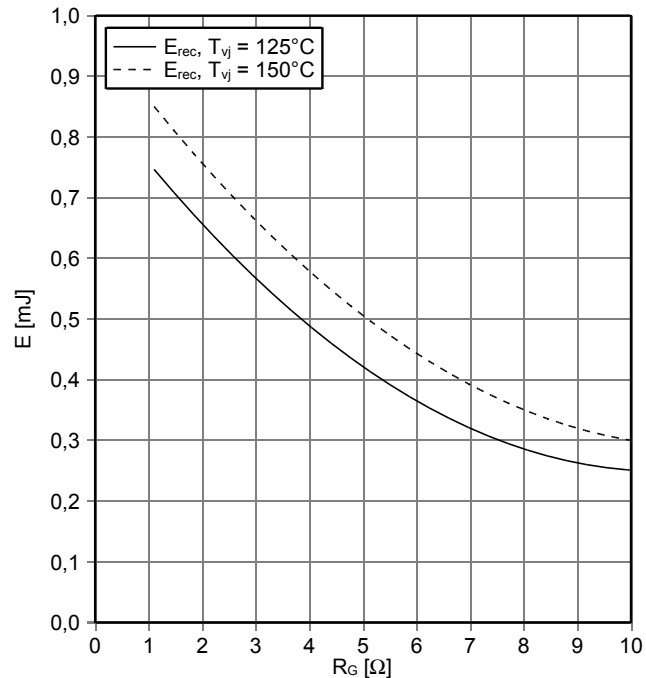
スイッチング損失 ダイオード, D2 / D3 (Typical)
switching losses Diode, D2 / D3 (typical)

$E_{rec} = f(I_F)$
 $R_{Gon} = 1.1 \Omega, V_{CE} = 400 V$



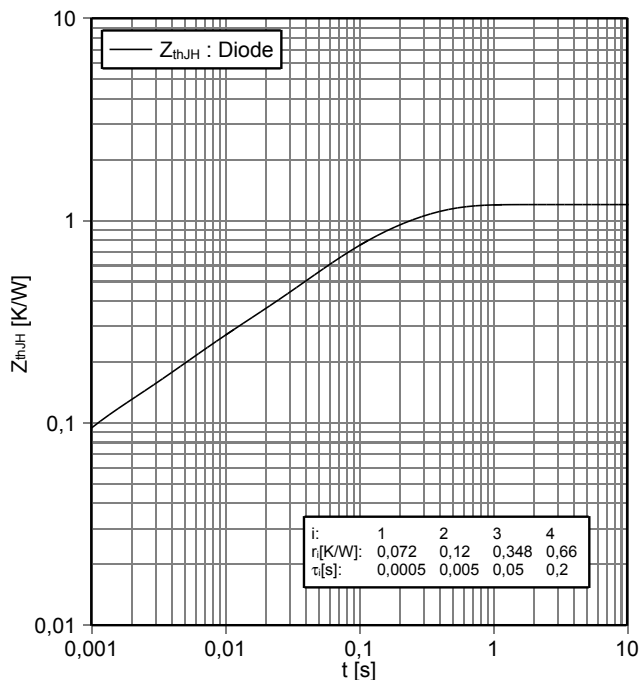
スイッチング損失 ダイオード, D2 / D3 (Typical)
switching losses Diode, D2 / D3 (typical)

$E_{rec} = f(R_G)$
 $I_F = 50 A, V_{CE} = 400 V$



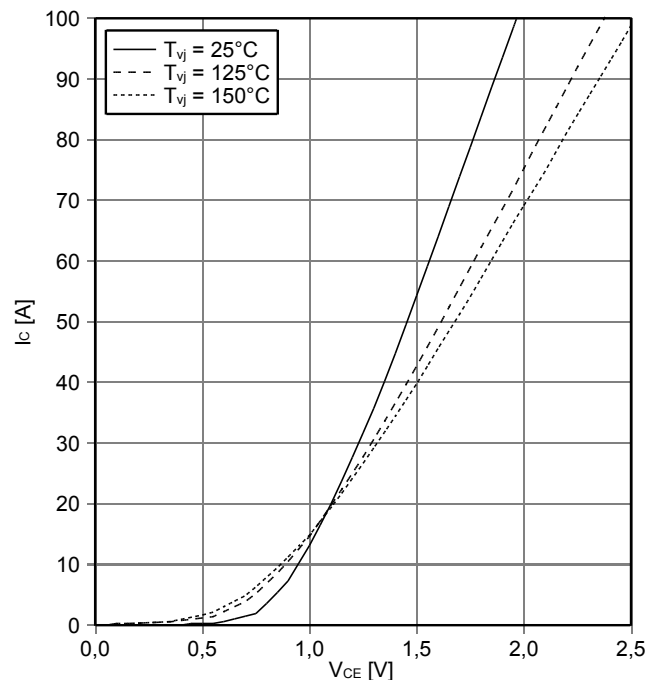
過渡熱インピーダンス ダイオード, D2 / D3
transient thermal impedance Diode, D2 / D3

$Z_{thJH} = f(t)$



出力特性 IGBT, T2 / T3 (Typical)
output characteristic IGBT, T2 / T3 (typical)

$I_C = f(V_{CE})$
 $V_{GE} = 15 V$



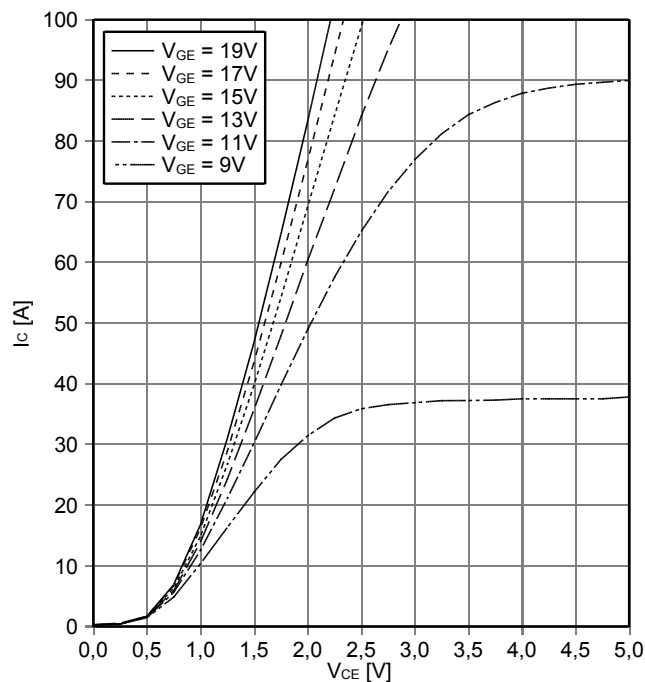
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暫定データ
Preliminary Data

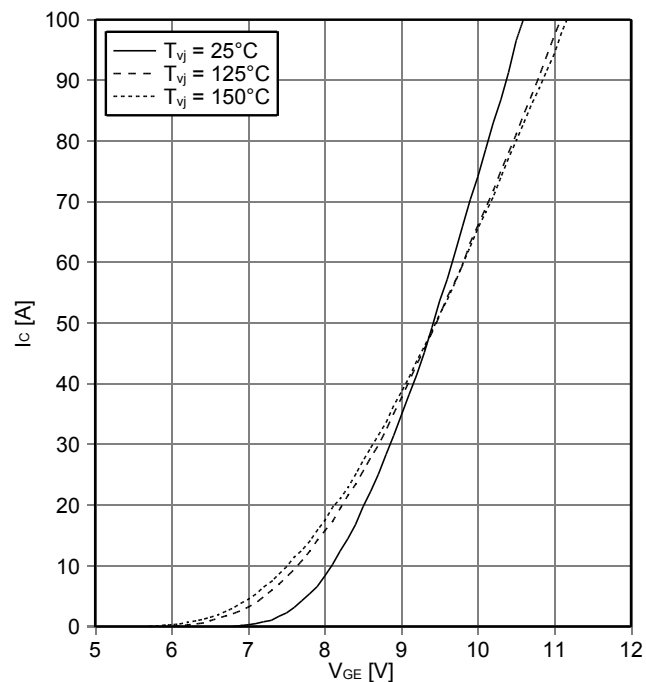
出力特性 IGBT, T2 / T3 (Typical)
output characteristic IGBT, T2 / T3 (typical)

$I_C = f(V_{CE})$
 $T_{vj} = 150^\circ\text{C}$



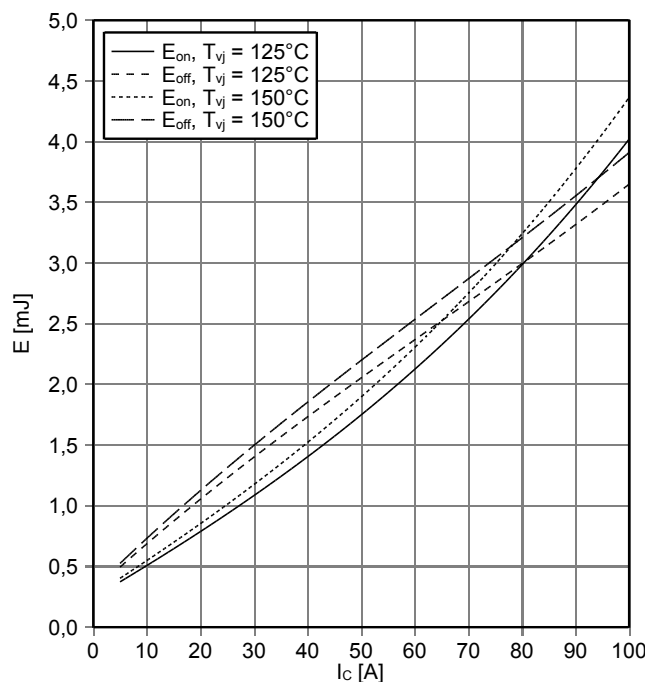
伝達特性 IGBT, T2 / T3 (Typical)
transfer characteristic IGBT, T2 / T3 (typical)

$I_C = f(V_{GE})$
 $V_{CE} = 20\text{ V}$



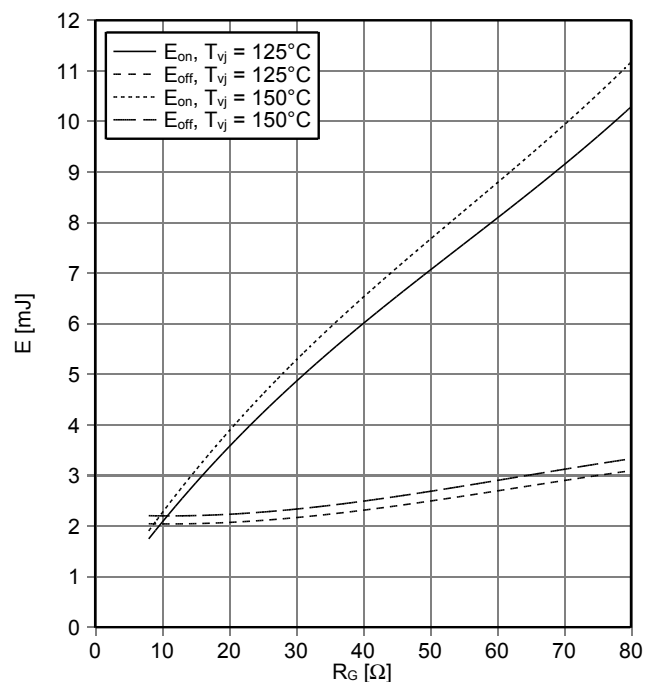
スイッチング損失 IGBT, T2 / T3 (Typical)
switching losses IGBT, T2 / T3 (typical)

$E_{on} = f(I_C), E_{off} = f(I_C)$
 $V_{GE} = \pm 15\text{ V}, R_{Gon} = 8.2\ \Omega, R_{Goff} = 8.2\ \Omega, V_{CE} = 400\text{ V}$



スイッチング損失 IGBT, T2 / T3 (Typical)
switching losses IGBT, T2 / T3 (typical)

$E_{on} = f(R_G), E_{off} = f(R_G)$
 $V_{GE} = \pm 15\text{ V}, I_C = 50\text{ A}, V_{CE} = 400\text{ V}$



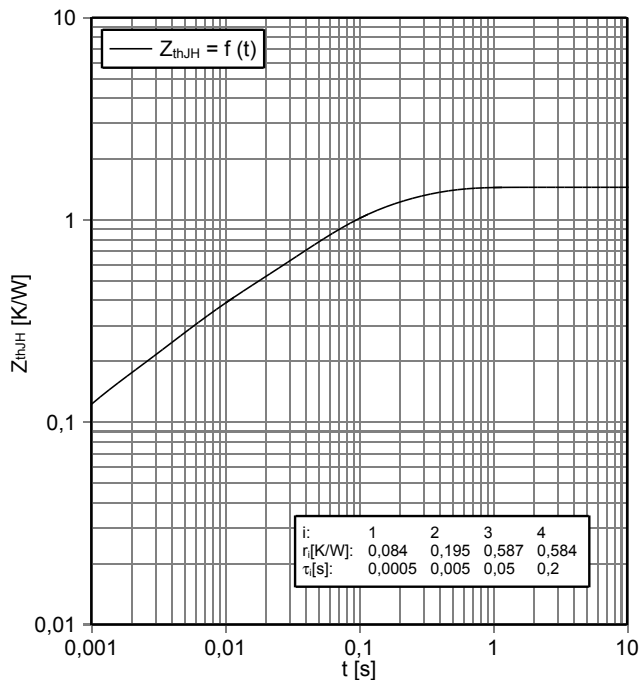
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暫定データ
Preliminary Data

過渡熱インピーダンス IGBT, T2 / T3
transient thermal impedance IGBT, T2 / T3

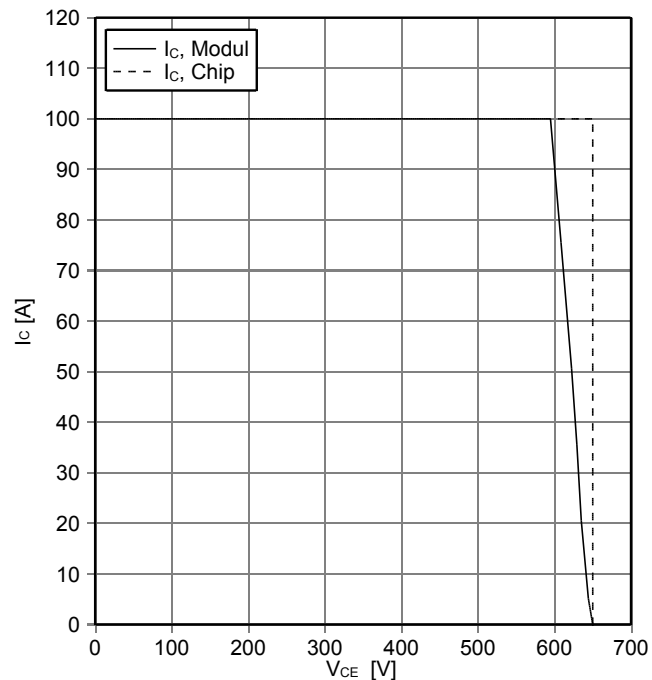
$Z_{thJH} = f(t)$



逆バイアス安全動作領域 IGBT, T2 / T3 (RBSOA))
reverse bias safe operating area IGBT, T2 / T3 (RBSOA)

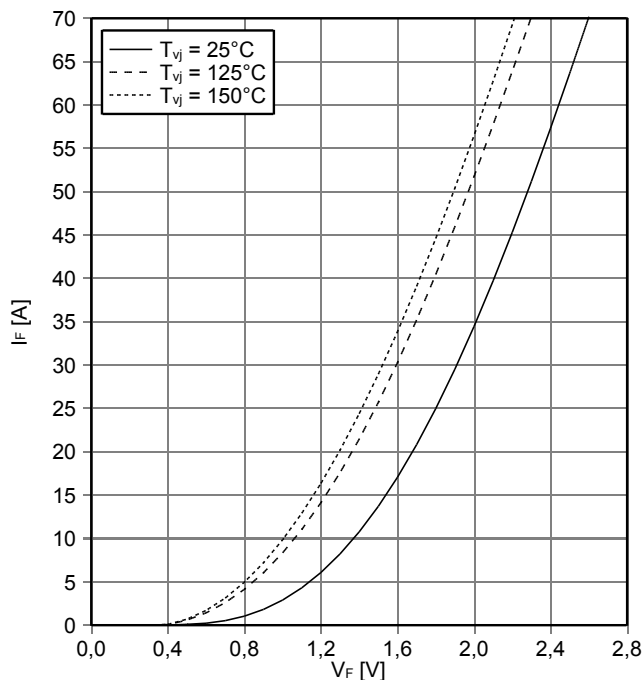
$I_C = f(V_{CE})$

$V_{GE} = \pm 15\text{ V}, R_{Goff} = 8.2\ \Omega, T_{vj} = 150^\circ\text{C}$



順電圧特性 ダイオード, D1 / D4 (typical)
forward characteristic of Diode, D1 / D4 (typical)

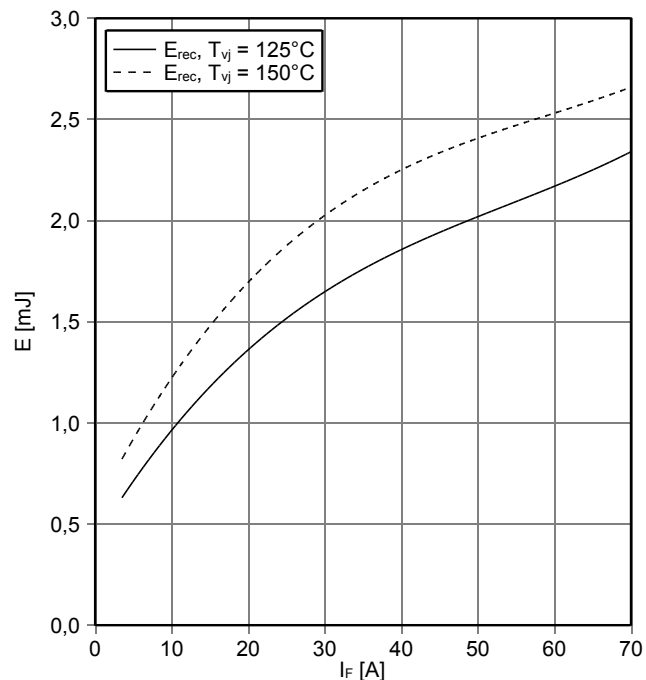
$I_F = f(V_F)$



スイッチング損失 ダイオード, D1 / D4 (Typical)
switching losses Diode, D1 / D4 (typical)

$E_{rec} = f(I_F)$

$R_{Gon} = 8.2\ \Omega, V_{CE} = 400\text{ V}$



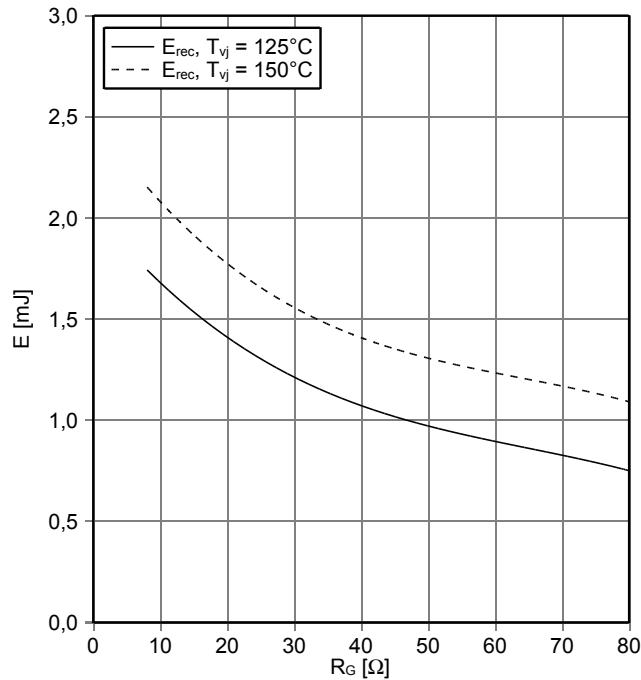
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Preliminary Data

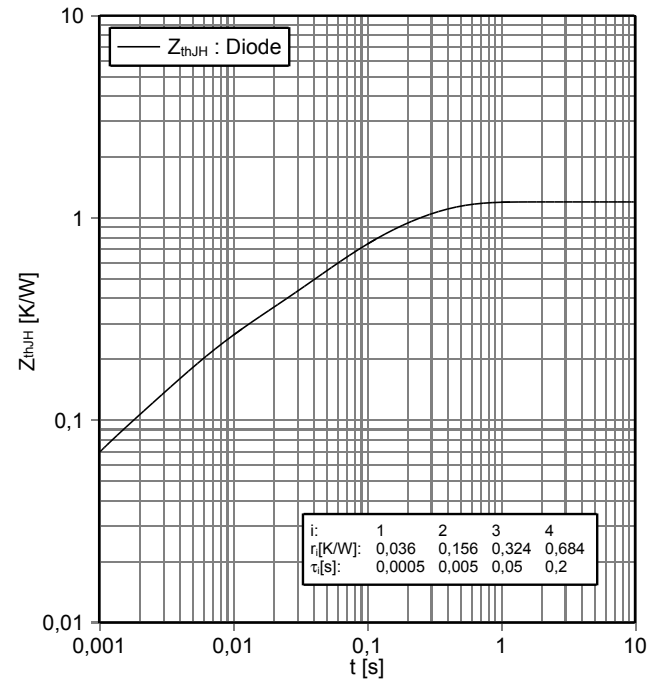
スイッチング損失 ダイオード, D1 / D4 (Typical)
switching losses Diode, D1 / D4 (typical)

$E_{rec} = f(R_G)$
 $I_F = 35\text{ A}, V_{CE} = 400\text{ V}$



過渡熱インピーダンス ダイオード, D1 / D4
transient thermal impedance Diode, D1 / D4

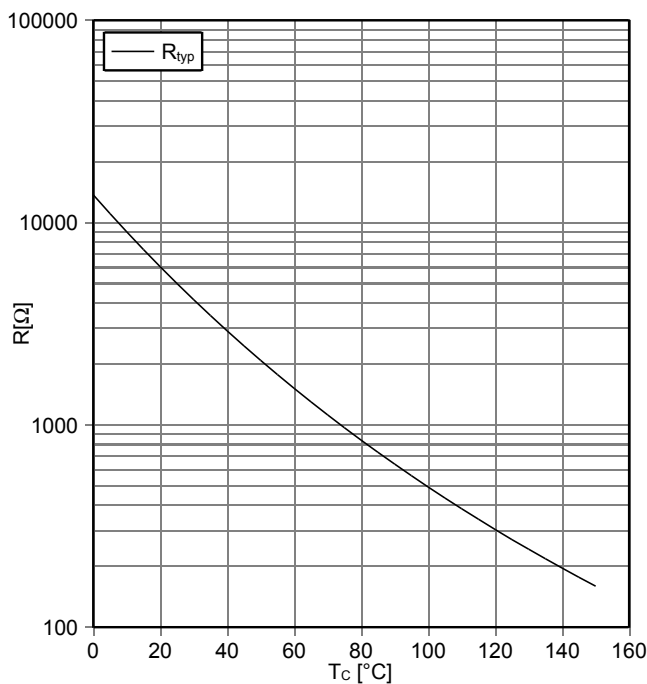
$Z_{thJH} = f(t)$



i:	1	2	3	4
r[K/W]:	0,036	0,156	0,324	0,684
τ[s]:	0,0005	0,005	0,05	0,2

NTC-サーミスタ サーミスタの温度特性
NTC-Thermistor-temperature characteristic (typical)

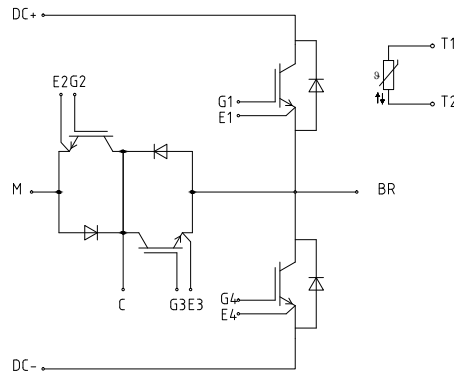
$R = f(T)$



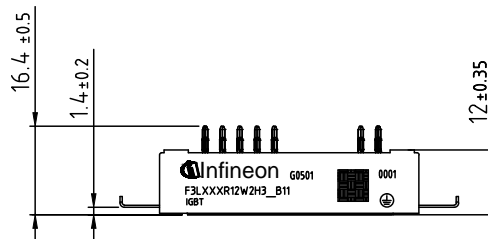
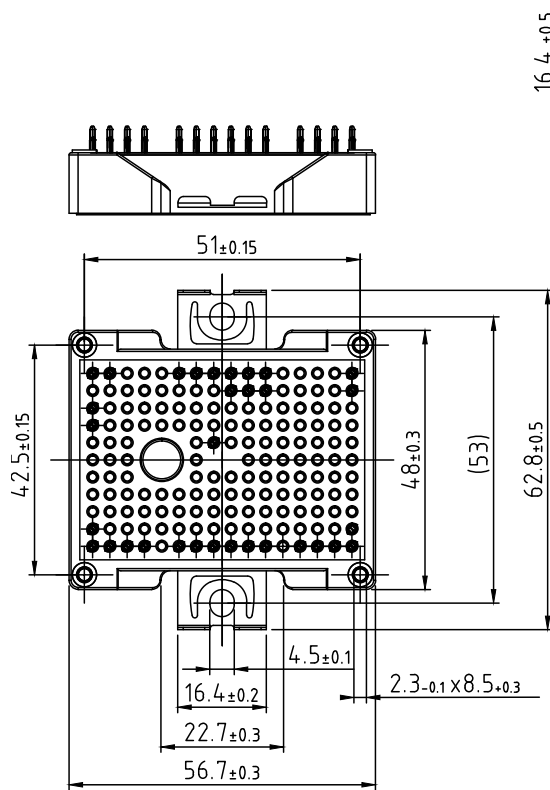
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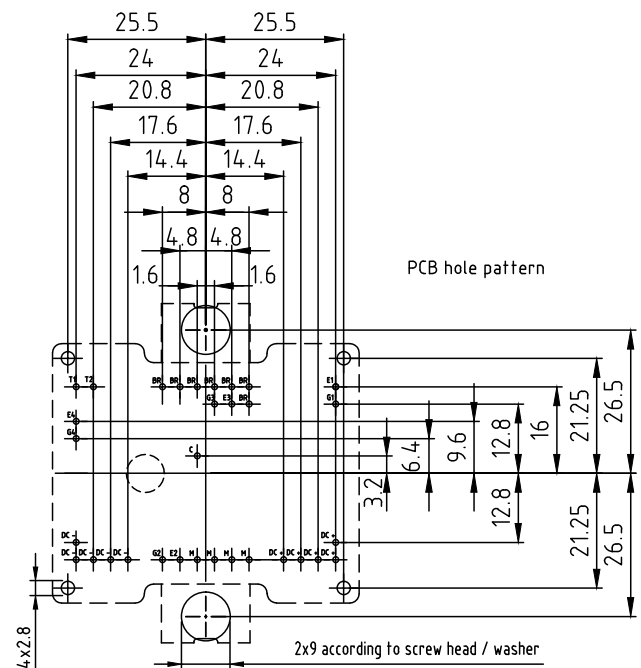
回路図 / circuit_diagram_headline



パッケージ概要 / package outlines



- Pin-Grid 3.2mm
- Tolerance of PCB hole pattern $\varnothing 0.1$
- Hole specification for contacts see AN 2009-01:
Diameters of drill $\varnothing 1.15\text{mm}$
and copper thickness in hole 25-50 μm



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- to perform joint Risk and Quality Assessments;

- the conclusion of Quality Agreements;

- to establish joint measures of an ongoing product survey, and that we may make delivery depended on the realization of any such measures.

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